TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74LCXR163245FT

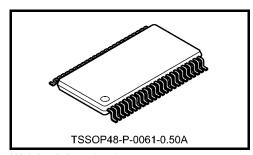
#### 16-Bit Dual Supply Bus Transceiver with Series Resistor

The TC74LCXR163245FT is a dual supply, advanced high-speed CMOS 16-bit dual supply voltage interface bus transceiver fabricated with silicon gate CMOS technology.

Designed for use as an interface between a 3.3-V or a 2.5-V bus and a 5-V bus in mixed 3.3-V or 2.5-V/5-V supply systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is intended for two-way asynchronous communication between data busses. The direction of data transmission is determined by the level of the DIR input. The enable input ( $\overline{\text{OE}}$ ) can be used to disable the device so that the buses are effectively isolated.

The B-port interfaces with the 3.3 V or 2.5 V bus, the A-port with the 5 V bus.



Weight: 0.25 g (typ.)

The  $26-\Omega$  series resistor helps reducing output overshoot and undershoot without external resistor. All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### Features (Note 1) (Note 2)

- Bidirectional interface between 3.3 V or 2.5 V buses and 5 V buses
- 26-Ω series resistors on outputs
- High-speed operation: t<sub>pd</sub> = 8.5 ns (max)

$$(V_{CCB} = 3.3 \pm 0.3 \text{ V/V}_{CCA} = 5 \pm 0.5 \text{ V}, \text{ Ta} = -40 \text{ to } 85^{\circ}\text{C})$$

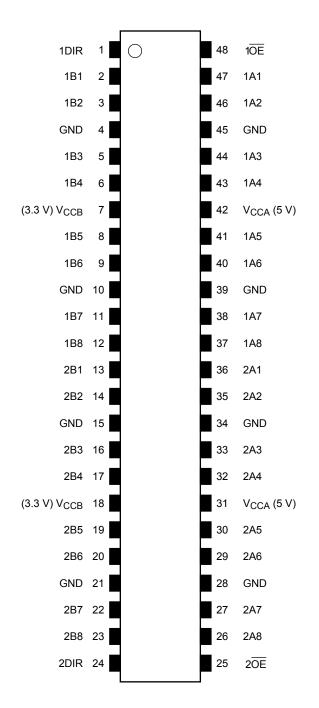
- Low-voltage operation:  $I_{CC} = 80 \mu A \text{ (max)}$  (Ta = -40 to 85°C)
- Symmetrical output impedance: I<sub>OUTB</sub> = ±12 mA (min)

$$I_{OUTA}$$
 = ±12 mA (min)  
(V<sub>CCB</sub> = 3.0 V/V<sub>CCA</sub> = 4.5 V)

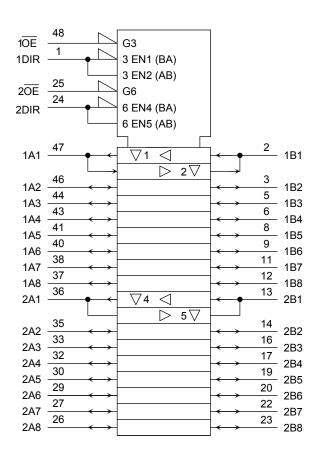
- Power-down protection provided on all inputs and outputs
- Allows A port and V<sub>CCA</sub> to float simultaneously in high state at  $\overline{\text{OE}}$  pin
- Latch-up performance: –500 mA
- ESD performance: Machine model > ±200 V (Note 2)
- Package: TSSOP
  - Note 1: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

    All floating (high impedance) bus pins must have their input fixed by means of pull-up or pull-down resistors.
  - Note 2: This device is electrostatic sensitivity (human body model > 1 kV). Please handle with caution.

#### Pin Assignment (top view)



## **IEC Logic Symbol**



## **Truth Table**

Inp	Inputs		ction			
1OE	1DIR	Bus Bus 1A1-1A8 1B1-1B8		Outputs		
L	L	Output	Input	A = B		
L	Н	Input	Output	B = A		
Н	Х	2	Z			

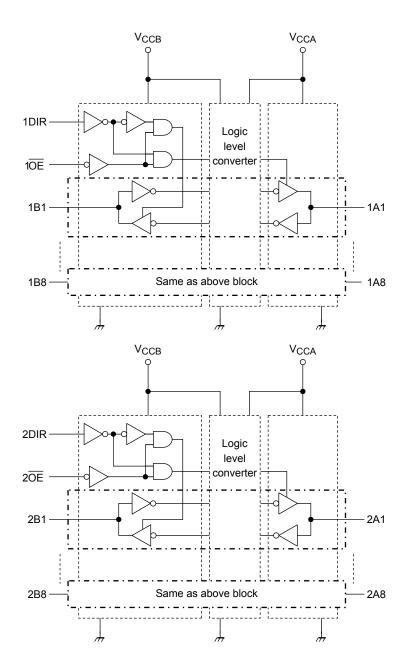
Inputs		Fun	ction			
2 <del>OE</del>	2DIR	Bus 2A1-2A8	Bus 2B1-2B8	Outputs		
L	L	Output	Input	A = B		
L	Н	Input	Output	B=A		
Н	Х	2	Z			

X: Don't care

Z: High impedance

## **Block Diagram**

**TOSHIBA** 





#### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit	
Power supply voltage (Note 2)	$V_{CCB}$	-0.5 to 7.0	V	
Power supply voltage (Note 2)	V <sub>CCA</sub>	–0.5 to 7.0	V	
DC input voltage (DIR, $\overline{\text{OE}}$ )	V <sub>IN</sub>	-0.5 to 7.0	V	
		-0.5 to 7.0 (Note 3)		
	V <sub>I/OB</sub>	-0.5 to V <sub>CCB</sub> + 0.5		
DC bus I/O voltage		(Note 4)	V	
DC bus 1/O voltage		-0.5 to 7.0 (Note 3)	•	
	V <sub>I/OA</sub>	-0.5 to V <sub>CCA</sub> + 0.5		
		(Note 4)		
Input diode current	I <sub>IK</sub>	-50	mA	
Output diode current	I <sub>I/OK</sub>	±50 (Note 5)	mA	
DC output ourront	I <sub>OUTB</sub>	±50	mA	
DC output current	I <sub>OUTA</sub>	±50	IIIA	
DC V <sub>CC</sub> /ground current per supply pin	I <sub>CCB</sub>	±100	mA	
DO vCC/ground current per supply pin	I <sub>CCA</sub>	±100	ШA	
Power dissipation	P <sub>D</sub>	400	mW	
Storage temperature	T <sub>stg</sub>	-65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

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Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: Don't supply a voltage to  $V_{CCA}$  terminal when  $V_{CCB}$  is in the OFF state.

Note 3: Output in OFF state

Note 4: High or low state. I<sub>OUT</sub> absolute maximum rating must be observed.

Note 5: V<sub>OUT</sub> < GND, V<sub>OUT</sub> > V<sub>CC</sub>



## **Operating Ranges (Note 1)**

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V <sub>CCB</sub>	2.3 to 3.6	V	
Tower supply voltage	V <sub>CCA</sub>	4.5 to 5.5		
Input voltage (DIR, $\overline{OE}$ )	V <sub>IN</sub>	0 to 5.5	<b>&gt;</b>	
	Vuon	0 to 5.5 (Note 2)		
DC bus I/O voltage	V <sub>I/OB</sub>	0 to V <sub>CCB</sub> (Note 3)	V	
DC bus I/O voltage	V	0 to 5.5 (Note 2)	V	
	V <sub>I/OA</sub>	0 to V <sub>CCA</sub> (Note 3)		
	la	±12 (Note 4)		
Output current	loutb	±4 (Note 5)	mA	
	IOUTA	±12 (Note 6)		
Operating temperature	T <sub>opr</sub>	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 7)	ns/V	

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND. Please connect both bus inputs and the bus outputs with VCC or GND when the I/O of the bus terminal changes by the function. In this case, please note that the output is not short-circuited.

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- Note 2: Output in OFF state
- Note 3: High or low state
- Note 4:  $V_{CCB} = 3.0 \text{ to } 3.6 \text{ V}$
- Note 5:  $V_{CCB} = 2.3 \text{ to } 2.7 \text{ V}$
- Note 6:  $V_{CCA} = 4.5 \text{ to } 5.5 \text{ V}$
- Note 7:  $V_{INB} = 0.8$  to 2.0 V,  $V_{CCB} = 3.0$  V
  - $V_{INA} = 0.8$  to 2.0 V,  $V_{CCA} = 5.0$  V



## **Electrical Characteristics**

#### **DC Characteristics**

Characteristics	Symbol	Test Condition		V <sub>CCB</sub> (V)	V <sub>CCA</sub> (V)		Ta = -40 to 85°C	
						Min	Max	
	V <sub>IHB</sub>	DIR, OE, Bn			$5.0 \pm 0.5$	1.7	_	
H-level input voltage	VIHB	DIIV, OL, DII		$3.3 \pm 0.3$	$5.0 \pm 0.5$	2.0	_	V
	V <sub>IHA</sub>	An		2.3 to 3.6	$5.0 \pm 0.5$	2.0	_	
	V <sub>ILB</sub>	DIR, OE, Bn		$2.5 \pm 0.2$	$5.0 \pm 0.5$	_	0.7	
L-level input voltage	- 125	2, 02,2		$3.3 \pm 0.3$	$5.0 \pm 0.5$	_	0.8	V
	V <sub>ILA</sub>	An	•	2.3 to 3.6	$5.0\pm0.5$	_	8.0	
	.,		I <sub>OHB</sub> = -100 μA	2.3 to 3.6	$5.0 \pm 0.5$	V <sub>CCB</sub> - 0.2	_	
	V <sub>OHB</sub>	V <sub>INA</sub> = V <sub>IHA</sub> or V <sub>ILA</sub>	$I_{OHB} = -12 \text{ mA}$	3.0	$5.0 \pm 0.5$	2.2	_	
H-level output voltage			I <sub>OHB</sub> = – 4 mA	2.3	$5.0 \pm 0.5$	1.8	_	V
	V <sub>OHA</sub>	V <sub>INB</sub> = V <sub>IHB</sub> or V <sub>ILB</sub>	$I_{OHA} = -100 \mu A$ $I_{OHA} = -12 \text{ mA}$	2.3 to 3.6	$5.0 \pm 0.5$	V <sub>CCA</sub> - 0.2	_	
				2.3 to 3.6	4.5	3.7		
	V <sub>OLB</sub>	VINA = VIHA OT VILA - VINB = VIHB OT VILB	V <sub>IHA</sub> or V <sub>ILA</sub> NB  I <sub>OLB</sub> = 4 mA	2.3 to 3.6	$5.0 \pm 0.5$	_	0.2	V
				3.0	$5.0 \pm 0.5$	_	0.8	
L-level output voltage				2.3	$5.0 \pm 0.5$		0.6	
	V <sub>OLA</sub>			2.3 to 3.6	$5.0 \pm 0.5$		0.2	
				2.3 to 3.6	4.5		0.7	
0.4444.055444	I <sub>OZB</sub>	$V_{IN} = V_{IHB}$ or $V_{ILB}$ $V_{I/OB} = V_{CCB}$ or GND		2.3 to 3.6	5.0 ± 0.5	_	±5.0	•
3-state output OFF state current	I <sub>OZA</sub>	$V_{IN} = V_{IHB}$ or $V_{I/OA} = V_{CCA}$ o		2.3 to 3.6	5.0 ± 0.5	_	±5.0	μА
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> (DIR, $\overline{\text{OE}}$ )	= V <sub>CCB</sub> or GND	3.6	5.5	_	±5.0	μА
Power-off leakage current	I <sub>OFF</sub>	$V_{INA}/V_{INB} = 0 to$	o 5.5 V	0	0		10	μА
	I <sub>CCB1</sub>	$V_{I/OA}$ = Open, $V_{CCA}$ = Open $V_{\overline{OE}}$ = $V_{CCB}$ , DIR = GND		3.6	Open	_	50	
Quiescent supply current	I <sub>CCB2</sub>	V <sub>INA</sub> = V <sub>CCA</sub> or GND		3.6	5.5	_	50	4
		V <sub>INB</sub> = V <sub>CCB</sub> or GND						μΑ
	ICCA	$V_{INA} = V_{CCA}$ or GND $V_{INB} = V_{CCB}$ or GND		3.6	5.5	_	80	
	Ісств	V <sub>INB</sub> = V <sub>CCB</sub> -	3.6	$5.0\pm0.5$	_	500		
	ICCTA	V <sub>INA</sub> = 3.4 V pe	r input	2.3 to 3.6	5.5	_	2.0	mA

## AC Characteristics (input: $t_r = t_f = 2.5 \text{ ns}$ , $R_L = 500 \Omega$ )

 $V_{\text{CCB}} = 3.3 \pm 0.3 \; \text{V}$ 

Characteristics	Symbol	Test Condition	CL (pF)	V <sub>CCA</sub> (V)	Ta = -40 to 85°C		Unit
					Min	Max	
Propagation delay time $(Bn \to An)$	t <sub>pLH</sub>	Land Da	50	5.0 ± 0.5	1.0	7.5	
3-state output enable time $(\overline{OE} \to An)$	t <sub>pZL</sub>	Input: Bn Output: An (DIR = "L")	50	5.0 ± 0.5	1.0	9.5	ns
3-state output disable time $(\ \overline{OE} \ \to An)$	t <sub>pLZ</sub> t <sub>pHZ</sub>	(0.11)	50	5.0 ± 0.5	1.0	9.5	
Propagation delay time $(An \to Bn)$	t <sub>pLH</sub> t <sub>pHL</sub>	Jacob Ap	50	5.0 ± 0.5	1.0	8.5	
3-state output enable time $(\ \overline{\sf OE} \ \to {\sf Bn})$	t <sub>pZL</sub> t <sub>pZH</sub>	Input: An Output: Bn (DIR = "H")	50	5.0 ± 0.5	1.0	9.5	ns
3-state output disable time $(\ \overline{OE} \ \to Bn)$	t <sub>pLZ</sub> t <sub>pHZ</sub>	,	50	5.0 ± 0.5	1.0	9.5	
Output to output skew	t <sub>osLH</sub> t <sub>osHL</sub>	(Note)	50	5.0 ± 0.5	_	1.0	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

## $V_{CCB}=2.5\pm0.2\;V$

Characteristics	Symbol	Test Condition	CL (pF)	V <sub>CCA</sub> (V)	Ta = -40 to 85°C		Unit	
					Min	Max		
Propagation delay time $(Bn \to An)$	t <sub>pLH</sub>		50	5.0 ± 0.5	1.0	9.0		
3-state output enable time $(\overline{\sf OE} \ \to {\sf An})$	t <sub>pZL</sub>	Input: Bn Output: An (DIR = "L")	50	5.0 ± 0.5	1.0	13.0	ns	
3-state output disable time $(\ \overline{\sf OE} \ \to {\sf An})$	t <sub>pLZ</sub> t <sub>pHZ</sub>	10.11	50	5.0 ± 0.5	1.0	14.0		
Propagation delay time (An → Bn)	t <sub>pLH</sub>	January An	30	5.0 ± 0.5	1.0	9.5		
3-state output enable time $(\overline{OE} \to Bn)$	t <sub>pZL</sub>	Input: An Output: Bn (DIR = "H")	30	5.0 ± 0.5	1.0	12.5	ns	
3-state output disable time $(\overline{OE} \to Bn)$	t <sub>pLZ</sub> t <sub>pHZ</sub>	(-·· · · · )	30	5.0 ± 0.5	1.0	10.0		
Output to output skew	t <sub>osLH</sub> t <sub>osHL</sub>	(Note)	30 or 50	5.0 ± 0.5	-	1.0	ns	

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Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, \ t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

## **Capacitive Characteristics (Ta = 25°C)**

 $V_{CCB} = 2.5, 3.3 V$ 

Characteristics		Symbol	Test Circuit	Test Condition	V <sub>CCA</sub> (V)	Тур.	Unit
Input capacitance		$C_{IN}$	_	DIR, OE	5.0	7	pF
Output capacitance		C <sub>I/O</sub>	_	An, Bn	5.0	8	pF
	(Note)	C <sub>PDA</sub>	_	$A \Rightarrow B (DIR = "H")$	5.0	20	- pF
Power dissipation capacitance				$B \Rightarrow A \; (DIR = ``L")$	5.0	66	
				$A \Rightarrow B (DIR = "H")$	5.0	34	nE
		C <sub>PDB</sub>	_	$B \Rightarrow A (DIR = "L")$	5.0	4	pF

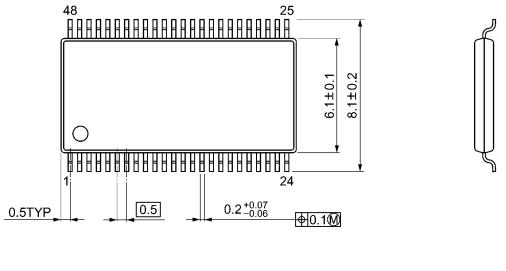
Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

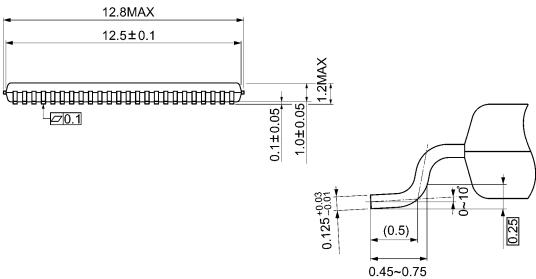
Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$ 

## **Package Dimensions**

TSSOP48-P-0061-0.50A Unit: mm





Weight: 0.25 g (typ.)

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